



DIM1500ASM33-TF001

Single Switch IGBT Module

DS6414-1 December 2022 (LN42294)

FEATURES

- 10.2kV Isolation
- 10µs Short Circuit Withstand
- High Thermal Cycling Capability
- Soft Punch Through Silicon
- High Current Density Enhanced DMOS
- Isolated AlSiC Base With AlN Substrates
- Lead Free Construction

APPLICATIONS

- High Reliability Inverters
- Motor Controllers
- Traction Drives
- Choppers

The Powerline range of high power modules includes half bridge, chopper, dual, single and bi-directional switch configurations covering voltages from 1200V to 6500V and currents up to 2400A.

The DIM1500ASM33-TF001 is a single switch 3300V, n-channel enhancement mode, insulated gate bipolar transistor (IGBT) module. The IGBT has a wide reverse bias safe operating area (RBSOA) plus 10µs short circuit withstand. This device is optimised for traction drives and other applications requiring high thermal cycling capability.

The module incorporates an electrically isolated base plate and low inductance construction enabling circuit designers to optimise circuit layouts and utilise grounded heat sinks for safety.

ORDERING INFORMATION

Order As:

DIM1500ASM33-TF001

Note: When ordering, please use the complete part number

KEY PARAMETERS

V _{CES}		3300V
V _{CE(sat)}	* (typ)	3.2V
l _c	(max)	1500A
I _{C(PK)}	(max)	3000A

^{*} Measured at the auxiliary terminals

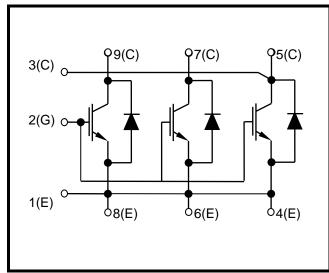


Fig. 1 Circuit configuration



Fig. 2 Package

ABSOLUTE MAXIMUM RATINGS

Stresses above those listed under 'Absolute Maximum Ratings' may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed. Exposure to Absolute Maximum Ratings may affect device reliability.

T_{case} = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Max.	Units
Vces	Collector-emitter voltage	V _{GE} = 0V	3300	V
V _{GES}	Gate-emitter voltage		±20	V
Ic	Continuous collector current	T _{case} = 104°C	1500	Α
I _{C(PK)}	Peak collector current	1ms, T _{case} = 137°C	3000	Α
P _{max}	Max. transistor power dissipation	T _{case} = 25°C, T _j = 150°C	15.6	kW
l²t	Diode I ² t value	$V_R = 0$, $t_p = 10$ ms, $T_j = 150$ °C	720	kA ² s
Visol	Isolation voltage – per module	Commoned terminals to base plate. AC RMS, 1 min, 50Hz	10.2	kV
Q_{PD}	Partial discharge – per module	IEC1287, V ₁ = 6900V, V ₂ = 5100V, 50Hz RMS	10	рС

THERMAL AND MECHANICAL RATINGS

Internal insulation material:

Baseplate material:

Creepage distance:

Clearance:

CTI (Comparative Tracking Index):

AIN

AISiC

56mm

26mm

>600

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
R _{th(j-c)}	Thermal resistance – transistor	Continuous dissipation - junction to case	-	-	8	°C/kW
R _{th(j-c)}	Thermal resistance – diode	Continuous dissipation - junction to case	-	-	16	°C/kW
R _{th(c-h)}	Thermal resistance – case to heatsink (per module)	Mounting torque 5Nm (with mounting grease)	-	-	6	°C/kW
Tj	Junction temperature	Transistor	-	-	150	°C
		Diode	-	-	150	°C
T _{stg}	Storage temperature range	-	-40	-	125	°C
		Mounting – M6	-	-	5	Nm
	Screw torque	Electrical connections – M4	-	-	2	Nm
		Electrical connections – M8	-	-	10	Nm

ELECTRICAL CHARACTERISTICS

 T_{case} = 25°C unless stated otherwise.

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
I _{CES}	Collector cut-off current	V _{GE} = 0V, V _{CE} = V _{CES}			5	mA
		V _{GE} = 0V, V _{CE} = V _{CES} , T _{case} = 125°C			90	mA
		V _{GE} = 0V, V _{CE} = V _{CES} , T _{case} = 150°C			150	mA
I _{GES}	Gate leakage current	V _{GE} = ± 20V, V _{CE} = 0V			1	μA
V _{GE(TH)}	Gate threshold voltage	Ic = 120mA, V _{GE} = V _{CE}		6.2		V
		V _{GE} = 15V, I _C = 1500A		3.2		V
V _{CE(sat)}	Collector-emitter saturation voltage	V _{GE} = 15V, I _C = 1500A, T _j = 125°C		3.7		V
	Saturation voltage	V _{GE} = 15V, I _C = 1500A, T _j = 150°C		3.8		V
l _F	Diode forward current	DC		1500		Α
I _{FM}	Diode maximum forward current	t _p = 1ms		3000		Α
	Diode forward voltage	I _F = 1500A		2.4		V
V _F		I _F = 1500A, T _j = 125°C		2.5		V
		I _F = 1500A, T _j = 150°C		2.4		V
Cies	Input capacitance	V _{CE} = 25V, V _{GE} = 0V, f = 1MHz		260		nF
Qg	Gate charge	±15V Including external C _{ge}		25		μC
Cres	Reverse transfer capacitance	V _{CE} = 25V, V _{GE} = 0V, f = 1MHz		6		nF
L _M	Module inductance			10		nΗ
RINT	Internal transistor resistance			90		μΩ
SC _{Data}	Short circuit current, Isc	$T_{j} = 150^{\circ}\text{C}, \ V_{CC} = 2500\text{V}$ $t_{p} \le 10\mu\text{s}, \ V_{GE} \le 15\text{V}$ $V_{CE \ (max)} = V_{CES} - L^{*} \ x \ dI/dt$ $IEC \ 60747-9$		5700		А

Note:

 $^{^{\}star}$ L is the circuit inductance + L_M

ELECTRICAL CHARACTERISTICS

 $T_{case} = 25$ °C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
t _{d(off)}	Turn-off delay time	I _C = 1500A		2360		ns
t f	Fall time	$V_{GE} = \pm 15V$		520		ns
Eoff	Turn-off energy loss	V _{CE} = 1800V		1030		mJ
t _{d(on)}	Turn-on delay time	$R_{g(ON)} = 1.65\Omega$ $R_{g(OFF)} = 1.5\Omega$		990		ns
t _r	Rise time	C _{GE} = 330nF L _S ~ 150nH		440		ns
Eon	Turn-on energy loss			1770		mJ
Qrr	Diode reverse recovery charge	I _F = 1500A		750		μC
Irr	Diode reverse recovery current	V _{CE} = 1800V		950		Α
Erec	Diode reverse recovery energy	$dI_F/dt = 4000A/\mu s$		920		mJ

T_{case} = 125°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
t _{d(off)}	Turn-off delay time	I _C = 1500A		2540		ns
t f	Fall time	$V_{GE} = \pm 15V$		540		ns
E _{OFF}	Turn-off energy loss	$V_{CE} = 1800V$		1630		mJ
t _{d(on)}	Turn-on delay time	$R_{g(ON)} = 1.65\Omega$ $R_{g(OFF)} = 1.5\Omega$ $C_{GE} = 330 nF$ $L_{S} \sim 150 nH$		935		ns
tr	Rise time			420		ns
Eon	Turn-on energy loss			2500		mJ
Qrr	Diode reverse recovery charge	I _F = 1500A		1280		μC
Irr	Diode reverse recovery current	V _{CE} = 1800V		1140		Α
Erec	Diode reverse recovery energy	dI _F /dt = 4000A/μs		1530		mJ

T_{case} = 150°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
t _{d(off)}	Turn-off delay time	I _C = 1500A		2570		ns
t _f	Fall time	$V_{GE} = \pm 15V$		570		ns
Eoff	Turn-off energy loss	V _{CE} = 1800V		1840		mJ
t _{d(on)}	Turn-on delay time	$R_{g(ON)} = 1.65\Omega$ $R_{g(OFF)} = 1.5\Omega$		910		ns
t _r	Rise time	$C_{GE} = 330nF$		420		ns
Eon	Turn-on energy loss	Ls ~ 150nH		2660		mJ
Qrr	Diode reverse recovery charge	I _F = 1500A V _{CE} = 1800V dI _F /dt = 4000A/μs		1510		μC
Irr	Diode reverse recovery current			1230		Α
Erec	Diode reverse recovery energy			1830		mJ

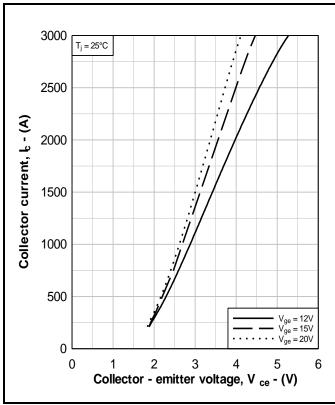


Fig. 3 Typical output characteristics

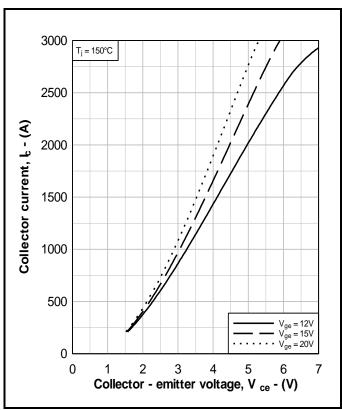


Fig. 4 Typical output characteristics

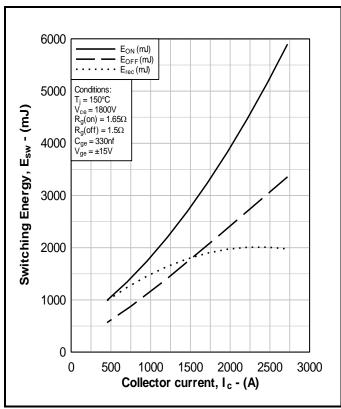


Fig. 5 Typical switching energy vs collector current

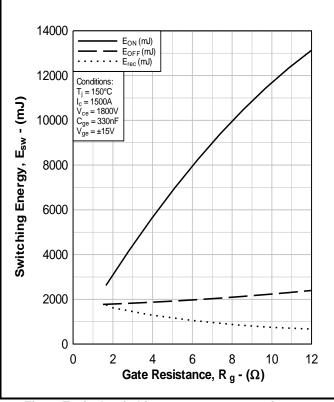


Fig. 6 Typical switching energy vs gate resistance

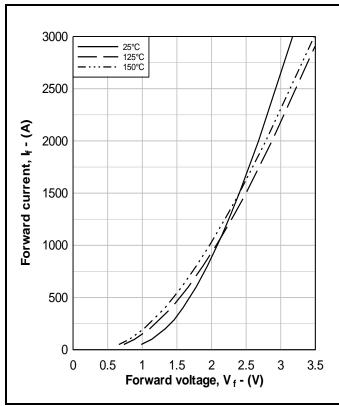


Fig. 7 Diode typical forward characteristics

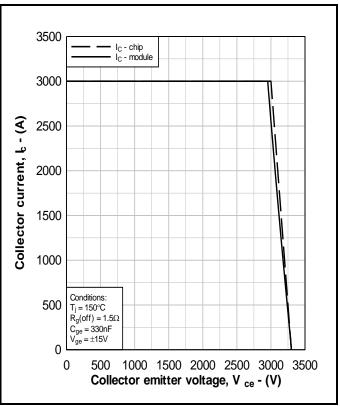


Fig. 8 Reverse bias safe operating area

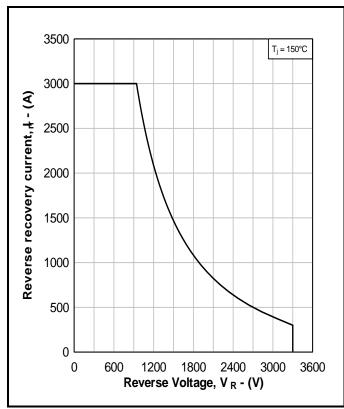


Fig. 9 Diode reverse bias safe operating area

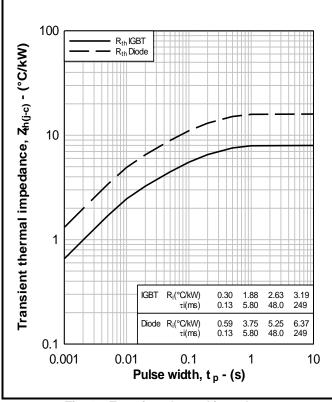


Fig. 10 Transient thermal impedance

PACKAGE DETAILS

For further package information, please visit our website or contact Customer Services. All dimensions in mm, unless stated otherwise.

DO NOT SCALE.

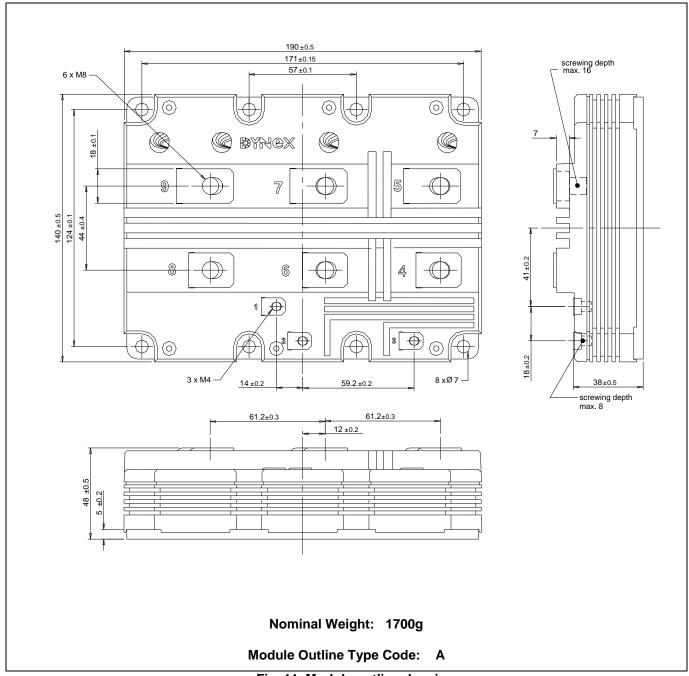


Fig. 11 Module outline drawing

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